

Notice of References Cited

Application/Control No.

10/559,736

Applicant(s)/Patent Under
Reexamination
FABIAN, HEINZ

Examiner

KEITH T. AZIZ

Art Unit

1791

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0230112	12-2003	Ikeda et al.	65/31
*	B	US-2002/0121109	09-2002	Aita, Kazuo	65/30.13
*	C	US-2001/0026997	10-2001	Henley et al.	438/458
*	D	US-5,676,724	10-1997	Barre et al.	65/382
*	E	US-5,198,008	03-1993	Thomas, Michael E.	65/386
*	F	US-4,898,777	02-1990	Kindler et al.	428/364
*	G	US-5,785,729	07-1998	Yokokawa et al.	65/385
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 59165005 A	09-1984	Japan	WATANABE, MINORU	
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.